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Photovoltaic effect in hybrid heterojunction formed from cadmium telluride and zinc perfluorophthalocyanine layers

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ABSTRACT

The results of the research on the photovoltaic effect in a planar system formed from the following layers: 19 ITO, CdTe, zinc perfulorophthalocyanine, bathocuproine and Ag (ITO/CdTe/ F_{16} ZnPc/BCP/Ag) are presented. 20 The system exhibited strong current rectification in the dark. A photogeneration of charge carriers in the 21 CdTe layer and at the CdTe/ F_{16} ZnPc junction was observed under illumination. The short-circuit current and 22 open-circuit voltage versus light intensity can be explained as a result of a trap-assisted recombination 23 process operating within the heterojunction. The current is limited by space charge for higher values of 24 forward bias.

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1. Introduction

Hybrid heterojunctions formed from organic and inorganic materials have recently attracted a great deal of attention due to their likely application in optoelectronic devices, and in solar cells in particular. Titanium dioxide (TiO₂) is most often used in such systems as an inorganic material, while polymers or phthalocyanines are applied as an organic material [1–5]. Intensive researches have been also conducted on bulk heterojunctions consisting of polymers and nanocrystals of other inorganic semiconductors such as CdS, CdSe, CuInS₂, ZnO, PbS, PbSe, Si [6–15] and CdTe [16,17].

This work presents the results of research on the photovoltaic effect in a system with planar heterojunction of CdTe/zinc perfluor-ophthalocyanine (F_{16} ZnPc). This heterojunction type has not been investigated yet. Both materials forming the junction have interesting photovoltaic properties. Cadmium telluride is a semiconductor widely applied in inorganic thin-film solar cells as a good absorber of sunlight [18–21]. Zinc perfluorophthalocyanine is an organic dye with good thermal stability, strong light absorption up to 900 nm and relatively high electron mobility [22,23].

The subject of investigation is a planar heterostructure formed from CdTe, F₁₆ZnPc, bathocuproine (BCP) and Ag subsequently evaporated in high vacuum onto a glass/ITO substrate. The system is abbreviated hereafter as ITO/CdTe/F₁₆ZnPc/BCP/Ag. The BCP plays the role of a buffer layer which acts as a carrier blocking layer, prevents the organic material from damage during Ag deposition and reduces resistance of contact [23,24]. When investigating the photovoltaic

effect in the ITO/CdTe/F₁₆ZnPc/BCP/Ag system particular attention 57 was paid to the electronic processes occurring at the CdTe/F₁₆ZnPc 58 interface.

2. Experimental details

The samples were made on glass substrates covered in a half by 61 indium tin oxide (ITO, 40 Ω /square from PGO). The substrates of glass/ 62 ITO after purification (ultrasonic baths in acetone and in isopropanol) 63 were placed into a vacuum system $(3 \cdot 10^{-4} \, \text{Pa}, \, \text{Auto } 306 \, \text{Turbo}, \, 64$ Edwards) and layers of CdTe (thickness 60 nm), F₁₆ZnPc (thickness 65 100 nm), BCP (thickness 15 nm) and Ag (thickness 40 nm) were 66 subsequently evaporated using thermal sublimation with an average 67 rate equal to 0.2 Å/s. CdTe (99.99%), F₁₆ZnPc and BCP were purchased 68 from Aldrich. Both organic materials were purified by sublimation in 69 advance. Four samples were produced in a single cycle. Each of them had 70 a 6 mm² active surface of electrodes. Additionally, the system without a 71 CdTe layer (i.e. ITO/F₁₆ZnPc/BCP/Ag), but with the same thicknesses of 72 F₁₆ZnPc, BCP and Ag layers as in the ITO/CdTe/F₁₆ZnPc/BCP/Ag system, 73 was made. The measurements were performed under ambient air at 74 room temperature using the apparatus described in the work [3]. The 75 samples were illuminated through the ITO.

3. Results and discussion

Fig. 1 shows the short-circuit current versus wavelength ($I_{sc}(\lambda)$) 78 obtained under constant flux of photons ($I_o=10^{15}$ ph/(cm² s)) and 79 absorption spectra of CdTe and F_{16} ZnPc layers. The short-circuit 80 current flows through the system from the Ag electrode to the ITO 81 electrode. Comparing the $I_{sc}(\lambda)$ curve with the absorption spectra it 82 can be noticed that the short-circuit current is determined by photons 83

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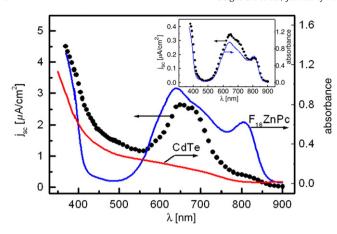


Fig. 1. Spectral dependence of short-circuit current of ITO/CdTe/ F_{16} ZnPc/BCP/Ag system and absorption spectra of CdTe and F_{16} ZnPc layers. Inset: spectrum of short-circuit current of ITO/ F_{16} ZnPc/BCP/Ag system and absorption spectrum of F_{16} ZnPc layer. The systems were illuminated with a light of constant flux of photons equal to 10^{15} ph/(cm² s).

absorbed in the CdTe layer as well as in the F₁₆ZnPc layer. When λ >550 nm the photogeneration of charge carriers via dissociation of excitons generated in the F₁₆ZnPc layer close to the interface of CdTe/ F_{16} ZnPc is noticeable in $I_{sc}(\lambda)$. This dissociation results in injection of a hole into a valence band of CdTe, while an electron moves towards the Ag electrode. The transfer of the hole to the layer of CdTe is possible, since the ionization energy of CdTe (5.8 eV [18]) is smaller than the ionization energy of F₁₆ZnPc (about 6.5 eV [25]). Within the range where λ <550 nm the I_{sc} (λ) curve correlates quite well with the absorption spectrum of CdTe and it indicates that photogeneration of charge carriers in CdTe dominates. The electrons generated as a result of band to band excitation are injected into F₁₆ZnPc, while holes move to the ITO electrode. In this case the transfer of electrons to F₁₆ZnPc is possible due to the fact that the electron affinity of CdTe (4.3 eV [18]) is smaller than the electron affinity of F_{16} ZnPc (about 4.6 eV [25]). In the short-circuit mode the transport of charge carriers through the system is determined by both their diffusion and drift in an inner electric field. The electric field appears as a result of alignment of the Fermi levels of electrodes and layers forming the system. It can be anticipated that the inner field in the considered system is directed from Ag to ITO due to the fact that the work function of ITO (4.7 eV [7]) is greater than the work function of Ag (4.3 eV [26]). This is also the direction of the short-circuit current in our system.

In order to reveal the consequence of the CdTe layer presence to our system we also performed measurements on a system without CdTe (i. e. ITO/ F_{16} ZnPc/BCP/Ag). The inset of Fig. 1 shows a spectrum of $I_{sc}(\lambda)$ obtained on this system and the absorption spectrum of F_{16} ZnPc. A good correlation between both the spectra (symbatic relation) within the whole range means that charge carriers are generated via dissociation of excitons at the ITO electrode: holes transfer to the ITO electrode, whereas electrons move through the system from ITO the layer with CdTe. When comparing the spectra of both systems, explicit differences in $I_{sc}(\lambda)$ resulting from the presence of the CdTe layer and the CdTe/ F_{16} ZnPc interface are noticeable. Moreover, the values of I_{sc} obtained on the system with CdTe are almost one order of magnitude higher than for the em without CdTe.

When investigating the system of ITO/CdTe/ F_{16T} ŹnPc/BCP/Ag we also performed measurements of the spectral dependence of open-circuit voltage $U_{oc}(\lambda)$. This curve exhibited, however, the same features as $I_{sc}(\lambda)$ and therefore it is not presented here.

Fig. 2 shows short-circuit current (I_{sc}) and open-circuit voltage (U_{oc}) as a function of light intensity (I_{o}) for a system illuminated with monochromatic light of 650 nm. This wavelength correlates with a peak in the $I_{sc}(\lambda)$ spectrum. The relationship of $I_{sc}(I_{o})$ is almost linear:

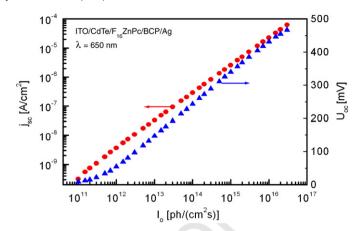


Fig. 2. Light intensity dependence of short-circuit current and open-circuit voltage for system when illuminated with monochromatic light of 650 nm.

 $I_{sc} \sim I_0^n$ with n=0.96. The linear relation means that either the short- 130 circuit current is not limited by a charge carrier recombination, and so 131 it equals the generation current, or a monomolecular recombination 132 via states trapping charge carriers operates within the junction [27]. 133 We anticipate, however, that it is rather the latter than the former 134 case that occurs in our system. It is suggested at least by the current- 135 voltage relationship for reverse bias (Fig. 3), since I_{sc} does not equal 136 the generation current (no explicit saturation of the reverse current 137 appears)

The $U_{oc}(I_o)$ relation presented in Fig. 2 can be extrapolated within 139 the range from 10^{12} ph/(cm² s) to $5 \cdot 10^{15}$ ph/(cm² s) as [28]:

$$U_{oc} = \frac{mkT}{e} \ln \left(\alpha I_o \right) \tag{1}$$

where kT/e is the thermal potential equal to 25 mV and $\alpha = 3.31 \times 142 \times 10^{-12} \, \text{cm}^2 \, \text{s}$, m = 1.68. The values of α and m depend on a model of 143 heterojunction. The case with m>1 is observed when a recombination 144 via trapping states operates in a junction [29,30]. If $I_o > 5 \cdot 10^{15} \, \text{ph}/$ 145 (cm² s), the $U_{oc}(I_o)$ relationship tends to saturate and we can estimate 146 the maximum open-circuit voltage value as $U_{ocmax} \approx 0.5 \div 0.6 \, \text{V}$. The 147 maximum open-circuit voltage value in bilayer systems is mainly 148 determined by the difference between the ionization energy of donor 149 (I_D) and the electron affinity of acceptor (A_C): $\Delta = I_D - A_C$. However, the 150

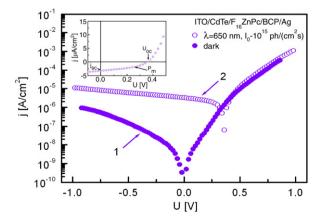


Fig. 3. Current density against applied voltage for system in dark (curve 1) and illuminated with monochromatic light of 650 nm and intensity of $I_o = 10^{15} \ ph/(cm^2 \ s)$ (curve 2 and inset). Inset: coordinates of P_m refer to photovoltaic power maximum: $U_m = 0.26 \ V$ and $j_m = 1.84 \ \mu A/cm^2$.

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values of U_{ocmax} obtained experimentally are smaller than Δ , usually by tens of eV [31]:

$$e U_{oc max} = \Delta - (0.3 \div 0.7) \text{eV}$$
 (2)

Taking into consideration that I_D of CdTe equals 5.8 eV and the A_C of F_{16} ZnPc is about 4.6 eV we obtain $\Delta = 1.2$ eV. It means that the empirical relation (2) is also fulfilled for our system. On the other hand, when describing the Uoc we should additionally take into account the role of the ITO/CdTe contact. Our research performed on ITO/CdTe/Ag confirms this thesis, since the illumination of ITO/CdTe/ Ag with the monochromatic light of $\lambda = 650 \text{ nm}$ and $I_0 = 10^{15} \text{ ph/}$ $(cm^2 s)$ generates $U_{oc} = 120$ mV and this open-circuit voltage is of the same polarity as in the system considered in this work. We come therefore to the conclusion that U_{oc} of ITO/CdTe/F₁₆ZnPc/BCP/Ag is generally a sum of voltages generated on the ITO/CdTe junction and the CdTe/ F_{16} ZnPc junction. However, for $\lambda = 650$ nm, U_{oc} is mainly dominated by the CdTe/F₁₆ZnPc junction.

Fig. 3 shows the dependence of dark current (curve 1) and photocurrent (curve 2 and inset) on the applied voltage. The positive voltage refers to the higher potential on ITO. The dark curve exhibits a strong current rectification effect. The rectification ratio yields 301 at U = 0.8 V. The reverse dark current seems to be formed by electrons injected from ITO into CdTe, since the estimated height of the barrier limiting this injection (the difference between the work function of ITO and the electron affinity of CdTe) is smaller than the height of the barrier limiting the hole injection from Ag into F₁₆ZnPc (the difference between the ionization energy of F₁₆ZnPc and the work function of Ag). For a forward bias (U>0) we can notice two distinct regions of the dark current-voltage curve. The following relation [28]:

$$j = j_o \exp\left(\frac{e|U|}{rkT}\right) \tag{3}$$

is fulfilled within the range from 0.08 V to 0.30 V with the diode quality factor r equal to 2.08 for kT/e = 25 mV. If the value of r is close to 2, then a current flowing through a system is determined by a recombination of charge carriers with unction. When U>0.6 V the power relation of the following forms:

$$j = AU^p \tag{4}$$

with p = 7.0 is a proper extrapolation of the experimental curve. This relation (i.e. when p>2) is observed in the case of space charge limited current flowing in the presence of traps with depths distributed exponentially [32]. The A factor depends, inter alia, on the trap concentration, charge carrier mobility and layer thickness. With respect to the above consideration, we can anticipate that the forward dark current is formed by electrons injected from the Ag electrode and by holes injected from the ITO electrode. The value of this current is limited either by the charge carrier recombination process within the junction or by the space charge. Due to the fact that the electric conductivity of CdTe is much higher than the electric conductivity of F₁₆ZnPc we anticipate that the space charge limiting transport of charge carriers through the system occurs mainly in F_{16} ZnPc.

Curve 2 and the inset in Fig. 3 show the photocurrent versus voltage for a system illuminated with monochromatic light of 10¹⁵ ph/ (cm² s) and 650 nm. The system exhibits photovoltaic effect with the following parameters: short-circuit current $j_{sc} = 3.3 \,\mu\text{A/cm}^2$, opencircuit voltage $U_{oc}\!=\!0.36\,V,$ fill factor FF $\!=\!(j_m\cdot U_m)/(j_{sc}\cdot U_{oc})\!=\!0.41$ (see inset) and power conversion efficiency $\eta = 0.16\%$. For forward bias, when U>0.6 V the photocurrent, as the dark current, can be extrapolated by the relation (4). Slightly higher values of the photocurrent than of the dark current should be related to the effect of photoconductivity in F₁₆ZnPc. The dependence of the photocurrent on voltage, when U<0.1 V, fulfills formally the relation (3), but with r = 32.8. However, such a big value of r does not find any grounds in a 211 simple heterojunction model, and so the relation (3) should be 212 treated as preliminary in an analysis of the reverse photocurrent- 213 voltage dependence of our system.

4. Summary 215

The work presents the results of the research on the photovoltaic 216 properties of a hybrid planar system formed by ITO/CdTe/F₁₆ZnPc/ 217 BCP/Ag. Such a system has not been investigated yet. Owing to the 218 spectral dependence of the short-circuit current we can reach a 219 conclusion that charge carriers can be generated both in the CdTe 220 layer (band to band transition) and as a result of exciton dissociation 221 at the CdTe/F₁₆ZnPc interface. On the other hand, the dependence of 222 short-circuit current and open-circuit voltage on light intensity 223 suggests that the trap-assisted recombination process operates in 224 the heterojunction of CdTe/F₁₆ZnPc. The system exhibits strong 225 current rectification in the dark. For the forward case the region 226 limited by recombination and the region limited by space charge can 227 be distinguishable in the dark current versus voltage curve. The 228 explanation of the dark current and photocurrent dependence on 229 voltage for a reverse case requires further investigation.

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